

SIPMOS® Small-Signal-Transistor

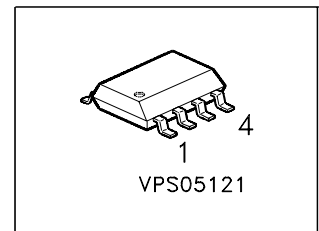
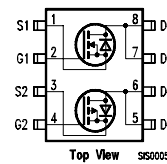
Features

- Dual N- and P -Channel
- Enhancement mode
- Logic Level
- Avalanche rated
- Pb-free lead plating; RoHS compliant

Product Summary

| | | N | P | |
|----------------------------------|--------------|------|-----|----------|
| Drain source voltage | V_{DS} | 60 | -60 | V |
| Drain-Source on-state resistance | $R_{DS(on)}$ | 0.11 | 0.3 | Ω |
| Continuous drain current | I_D | 3.1 | -2 | A |

| Type | Package | Marking |
|-----------|----------|---------|
| BSO 615 C | PG-DSO-8 | 615C |



Maximum Ratings, at $T_j = 25\text{ °C}$, unless otherwise specified

| Parameter | Symbol | Value | | Unit |
|---|---------------------|------------|------------|--------------------|
| | | N | P | |
| Continuous drain current $T_A = 25\text{ °C}$ $T_A = 70\text{ °C}$ | I_D | 3.1 2.5 | -2 -1.6 | A |
| Pulsed drain current $T_A = 25\text{ °C}$ | $I_{D\text{ puls}}$ | 12.4 | -8 | |
| Avalanche energy, single pulse $I_D = 3.1\text{ A}$, $V_{DD} = 25\text{ V}$, $R_{GS} = 25\text{ }\Omega$ $I_D = -2\text{ A}$, $V_{DD} = -25\text{ V}$, $R_{GS} = 25\text{ }\Omega$ | E_{AS} | 47 - | - 70 | mJ |
| Avalanche energy, periodic limited by T_{jmax} | E_{AR} | 0.2 | 0.2 | |
| Reverse diode dv/dt , $T_{jmax} = 150\text{ °C}$ $I_S = 3.1\text{ A}$, $V_{DS} = 48\text{ V}$, $di/dt = 200\text{ A}/\mu\text{s}$ $I_S = -2\text{ A}$, $V_{DS} = -48\text{ V}$, $di/dt = -200\text{ A}/\mu\text{s}$ | dv/dt | 6 - | - 6 | kV/ μs |
| Gate source voltage | V_{GS} | ± 20 | ± 20 | V |
| Power dissipation $T_A = 25\text{ °C}$ | P_{tot} | 2 | 2 | W |
| Operating and storage temperature | T_j, T_{stg} | -55...+150 | | $^{\circ}\text{C}$ |
| IEC climatic category; DIN IEC 68-1 | | 55/150/56 | | |

Thermal Characteristics

| Parameter | Symbol | Values | | | Unit |
|-----------|--------|--------|------|------|------|
| | | min. | typ. | max. | |

Dynamic Characteristics

| | | | | | | |
|---|---|------------|---|---|------|-----|
| Thermal resistance, junction - soldering point (Pin 4) | N | R_{thJS} | - | - | 40 | K/W |
| | P | | - | - | 40 | |
| SMD version, device on PCB: @ min. footprint; $t \leq 10$ sec. @ 6 cm ² cooling area 1); $t \leq 10$ sec. @ min. footprint; $t \leq 10$ sec. @ 6 cm ² cooling area 1); $t \leq 10$ sec. | N | R_{thJA} | - | - | 100 | |
| | N | | - | - | 62.5 | |
| | P | | - | - | 110 | |
| | P | | - | - | 62.5 | |

Static Characteristics, at $T_j = 25$ °C, unless otherwise specified

| | | | | | | |
|---|---|---------------|-----|------|------|----------|
| Drain- source breakdown voltage $V_{GS} = 0$ V, $I_D = 250$ μ A $V_{GS} = 0$ V, $I_D = -250$ μ A | N | $V_{(BR)DSS}$ | 60 | - | - | V |
| | P | | -60 | - | - | |
| Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D = 20$ μ A $I_D = -450$ μ A | N | $V_{GS(th)}$ | 1.2 | 1.6 | 2.0 | |
| | P | | -1 | -1.5 | -2.0 | |
| Zero gate voltage drain current $V_{DS} = 60$ V, $V_{GS} = 0$ V, $T_j = 25$ °C $V_{DS} = 60$ V, $V_{GS} = 0$ V, $T_j = 125$ °C $V_{DS} = -60$ V, $V_{GS} = 0$ V, $T_j = 25$ °C $V_{DS} = -60$ V, $V_{GS} = 0$ V, $T_j = 125$ °C | N | I_{DSS} | - | 0.1 | 1 | μ A |
| | N | | - | 10 | 100 | |
| | P | | - | -0.1 | -1 | |
| | P | | - | -10 | -100 | |
| Gate-source leakage current $V_{GS} = 20$ V, $V_{DS} = 0$ V $V_{GS} = -20$ V, $V_{DS} = 0$ V | N | I_{GSS} | - | 10 | 100 | nA |
| | P | | - | -10 | -100 | |
| Drain-source on-state resistance $V_{GS} = 4.5$ V, $I_D = 2.7$ A $V_{GS} = -4.5$ V, $I_D = -1.7$ A | N | $R_{DS(on)}$ | - | 0.1 | 0.15 | Ω |
| | P | | - | 0.27 | 0.45 | |
| Drain-source on-state resistance $V_{GS} = 10$ V, $I_D = 3.1$ A $V_{GS} = -10$ V, $I_D = -2$ A | N | $R_{DS(on)}$ | - | 0.07 | 0.11 | |
| | P | | - | 0.19 | 0.3 | |

¹Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical without blown air.

Electrical Characteristics, at $T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified

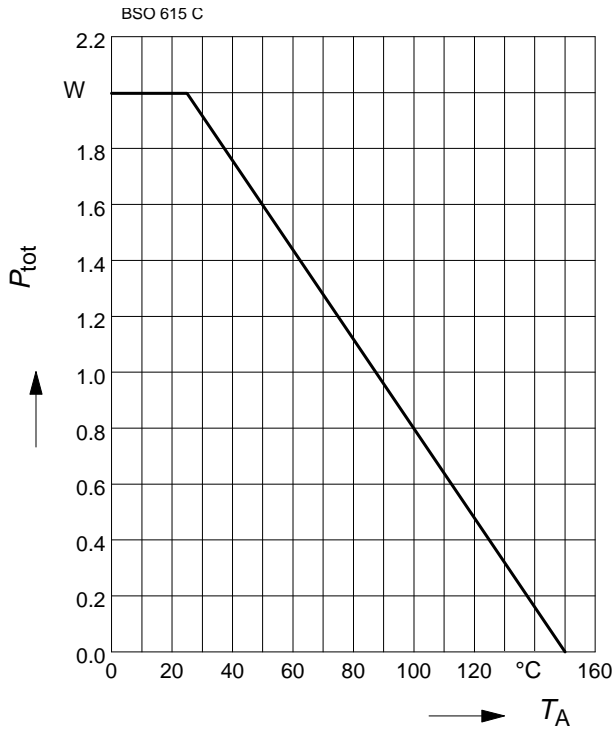
| Parameter | Symbol | Values | | | Unit | |
|---|--------|--------------|------|------|------|----|
| | | min. | typ. | max. | | |
| Characteristics | | | | | | |
| Transconductance | | g_{fs} | | | | S |
| $V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}$, $I_D = 2.7\text{ A}$ | N | | 2.25 | 5.5 | - | |
| $V_{V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}}$, $I_D = -1.7\text{ A}$ | P | | 1.2 | 2.4 | - | |
| Input capacitance | | C_{iss} | | | | pF |
| $V_{GS} = 0\text{ V}$, $V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$ | N | | - | 300 | 380 | |
| $V_{GS} = 0\text{ V}$, $V_{DS} = -25\text{ V}$, $f = 1\text{ MHz}$ | P | | - | 365 | 460 | |
| Output capacitance | | C_{oss} | | | | |
| $V_{GS} = 0\text{ V}$, $V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$ | N | | - | 90 | 120 | |
| $V_{GS} = 0\text{ V}$, $V_{DS} = -25\text{ V}$, $f = 1\text{ MHz}$ | P | | - | 105 | 135 | |
| Reverse transfer capacitance | | C_{rss} | | | | |
| $V_{GS} = 0\text{ V}$, $V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$ | N | | - | 50 | 65 | |
| $V_{GS} = 0\text{ V}$, $V_{DS} = -25\text{ V}$, $f = 1\text{ MHz}$ | P | | - | 40 | 50 | |
| Turn-on delay time | | $t_{d(on)}$ | | | | ns |
| $V_{DD} = 30\text{ V}$, $V_{GS} = 4.5\text{ V}$, $I_D = 2.7\text{ A}$, $R_G = 16\text{ }\Omega$ | N | | - | 16 | 24 | |
| $V_{DD} = -30\text{ V}$, $V_{GS} = -4.5\text{ V}$, $I_D = -1.7\text{ A}$, $R_G = 13\text{ }\Omega$ | P | | - | 24 | 36 | |
| Rise time | | t_r | | | | |
| $V_{DD} = 30\text{ V}$, $V_{GS} = 4.5\text{ V}$, $I_D = 2.7\text{ A}$, $R_G = 16\text{ }\Omega$ | N | | - | 75 | 115 | |
| $V_{DD} = -30\text{ V}$, $V_{GS} = -4.5\text{ V}$, $I_D = -1.7\text{ A}$, $R_G = 13\text{ }\Omega$ | P | | - | 105 | 160 | |
| Turn-off delay time | | $t_{d(off)}$ | | | | |
| $V_{DD} = 30\text{ V}$, $V_{GS} = 4.5\text{ V}$, $I_D = 2.7\text{ A}$, $R_G = 16\text{ }\Omega$ | N | | - | 25 | 40 | |
| $V_{DD} = -30\text{ V}$, $V_{GS} = -4.5\text{ V}$, $I_D = -1.7\text{ A}$, $R_G = 13\text{ }\Omega$ | P | | - | 125 | 190 | |
| Fall time | | t_f | | | | |
| $V_{DD} = 30\text{ V}$, $V_{GS} = 4.5\text{ V}$, $I_D = 2.7\text{ A}$, $R_G = 16\text{ }\Omega$ | N | | - | 18 | 27 | |
| $V_{DD} = -30\text{ V}$, $V_{GS} = -4.5\text{ V}$, $I_D = -1.7\text{ A}$, $R_G = 13\text{ }\Omega$ | P | | - | 90 | 135 | |

Electrical Characteristics, at $T_j = 25\text{ °C}$, unless otherwise specified

| Parameter | Symbol | Values | | | Unit | |
|--|--------|------------------------|--------|-------------|-------------|----|
| | | min. | typ. | max. | | |
| Characteristics | | | | | | |
| Gate to source charge $V_{DD} = 48\text{ V}$, $I_D = 3.1\text{ A}$ $V_{DD} = -48\text{ V}$, $I_D = -2\text{ A}$ | N P | Q_{gs} | - - | 0.5 1.7 | 0.75 2.6 | nC |
| Gate to drain charge $V_{DD} = 48\text{ V}$, $I_D = 3.1\text{ A}$ $V_{DD} = -48\text{ V}$, $I_D = -2\text{ A}$ | N P | Q_{gd} | - - | 6.3 4.3 | 9.5 6.5 | |
| Gate charge total $V_{DD} = 48\text{ V}$, $I_D = 3.1\text{ A}$, $V_{GS} = 0\text{ to }10\text{ V}$ $V_{DD} = -48\text{ V}$, $I_D = -2\text{ A}$, $V_{GS} = 0\text{ to }-10\text{ V}$ | N P | Q_g | - - | 15 13.5 | 22.5 20 | |
| Gate plateau voltage $V_{DD} = 48\text{ V}$, $I_D = 3.1\text{ A}$ $V_{DD} = -48\text{ V}$, $I_D = -2\text{ A}$ | N P | $V_{(\text{plateau})}$ | - - | 3.1 -2.8 | - - | V |
| Reverse Diode | | | | | | |
| Inverse diode continuous forward current $T_A = 25\text{ °C}$ | N P | I_S | - - | - - | 3.1 -2 | A |
| Inverse diode direct current, pulsed $T_A = 25\text{ °C}$ | N P | I_{SM} | - - | - - | 12.4 -8 | |
| Inverse diode forward voltage $V_{GS} = 0\text{ V}$, $I_F = I_S$ $V_{GS} = 0\text{ V}$, $I_F = I_S$ | N P | V_{SD} | - - | 0.8 -0.8 | 1.1 -1.1 | V |
| Reverse recovery time $V_R = 30\text{ V}$, $I_F = I_S$, $di_F/dt = 100\text{ A}/\mu\text{s}$ $V_R = -30\text{ V}$, $I_F = I_S$, $di_F/dt = -100\text{ A}/\mu\text{s}$ | N P | t_{rr} | - - | 50 85 | 75 130 | ns |
| Reverse recovery charge $V_R = 30\text{ V}$, $I_F = I_S$, $di_F/dt = 100\text{ A}/\mu\text{s}$ $V_R = -30\text{ V}$, $I_F = I_S$, $di_F/dt = -100\text{ A}/\mu\text{s}$ | N P | Q_{rr} | - - | 70 120 | 105 180 | nC |

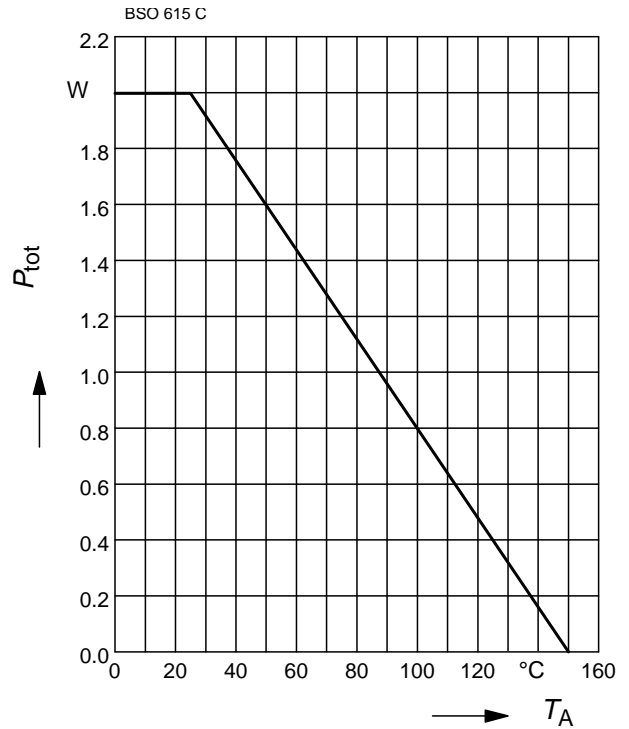
Power Dissipation (N-Ch.)

$$P_{tot} = f(T_A)$$



Power Dissipation (P-Ch.)

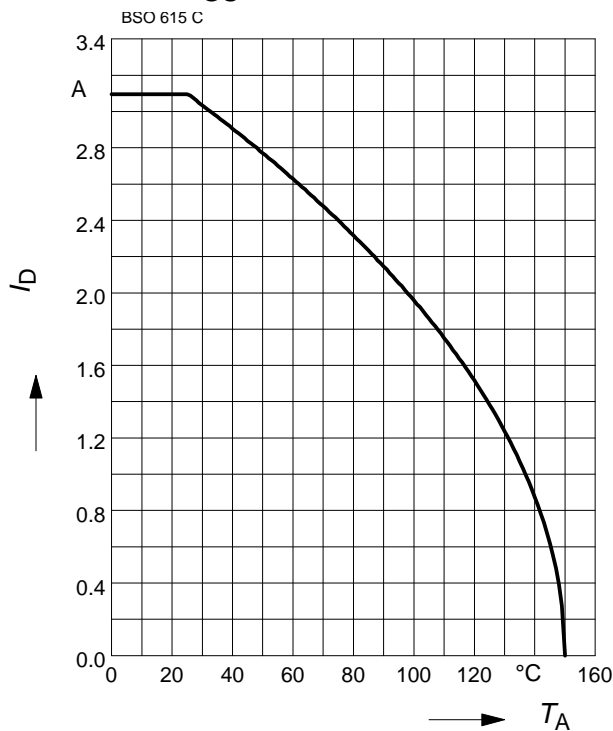
$$P_{tot} = f(T_A)$$



Drain current (N-Ch.)

$$I_D = f(T_A)$$

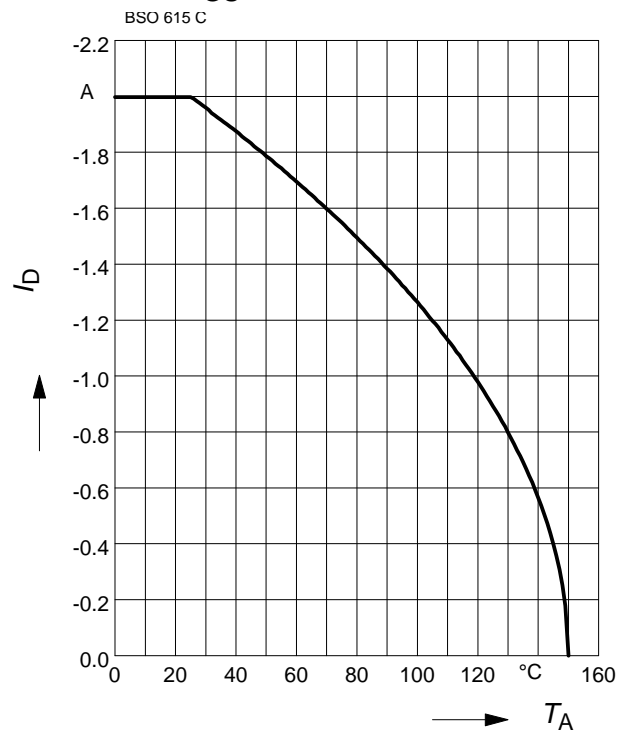
parameter: $V_{GS} \geq 10 \text{ V}$



Drain current (P-Ch.)

$$I_D = f(T_A)$$

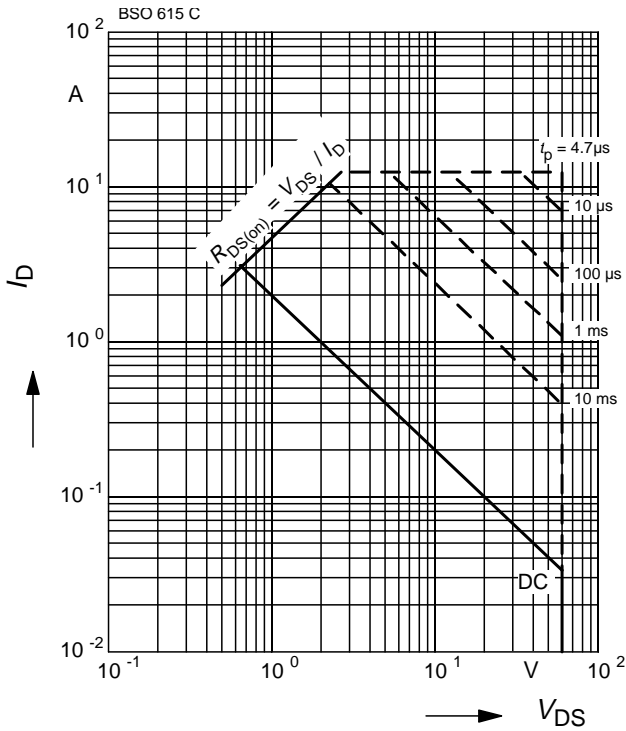
parameter: $V_{GS} \geq -10 \text{ V}$



Safe operating area (N-Ch.)

$$I_D = f(V_{DS})$$

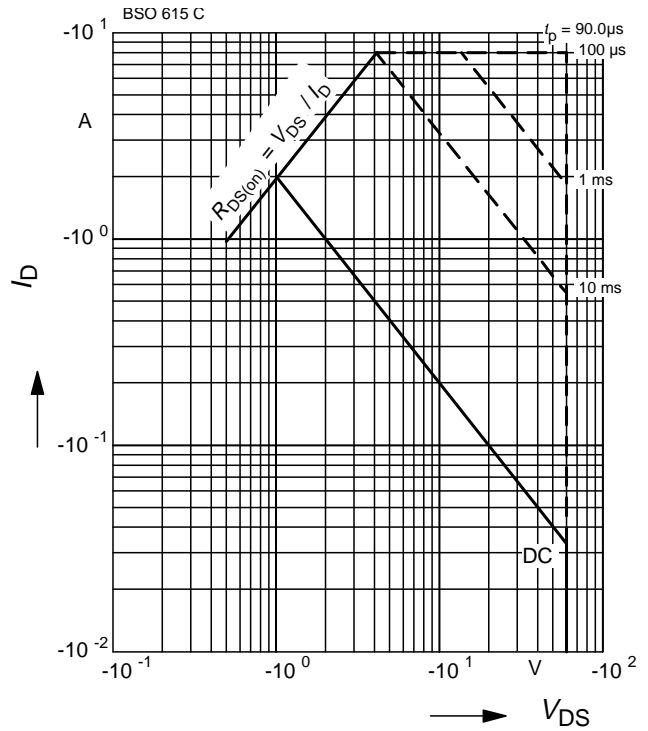
parameter : $D = 0, T_A = 25\text{ }^\circ\text{C}$



Safe operating area (P-Ch.)

$$I_D = f(V_{DS})$$

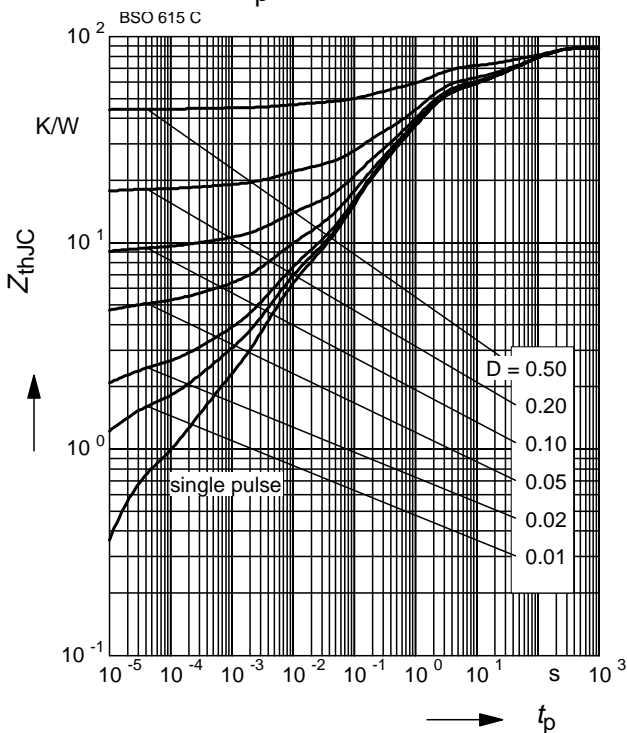
parameter : $D = 0, T_A = 25\text{ }^\circ\text{C}$



Transient thermal impedance (N-Ch.)

$$Z_{thJC} = f(t_p)$$

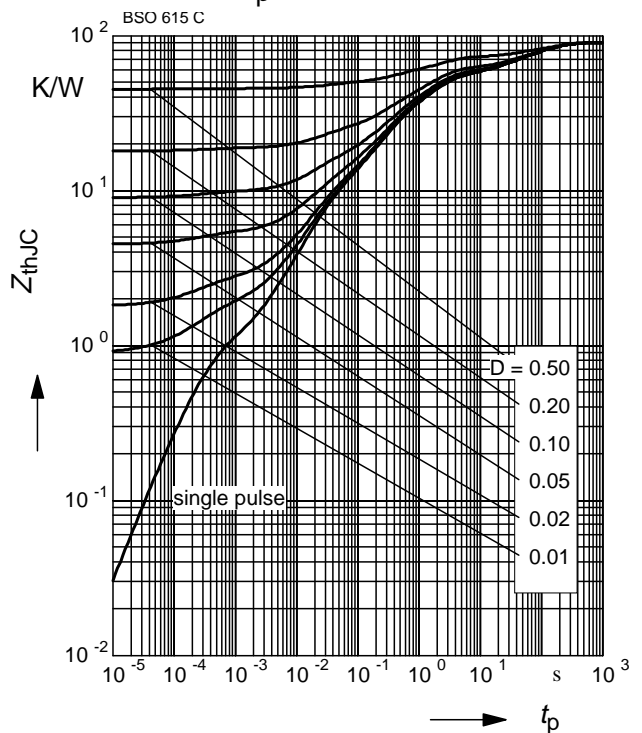
parameter : $D = t_p/T$



Transient thermal impedance (P-Ch.)

$$Z_{thJC} = f(t_p)$$

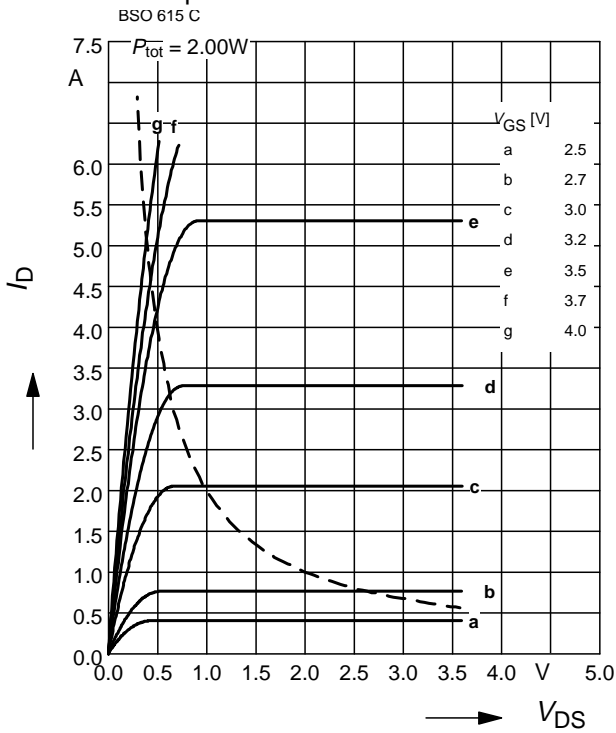
parameter : $D = t_p/T$



Typ. output characteristics (N-Ch.)

$$I_D = f(V_{DS})$$

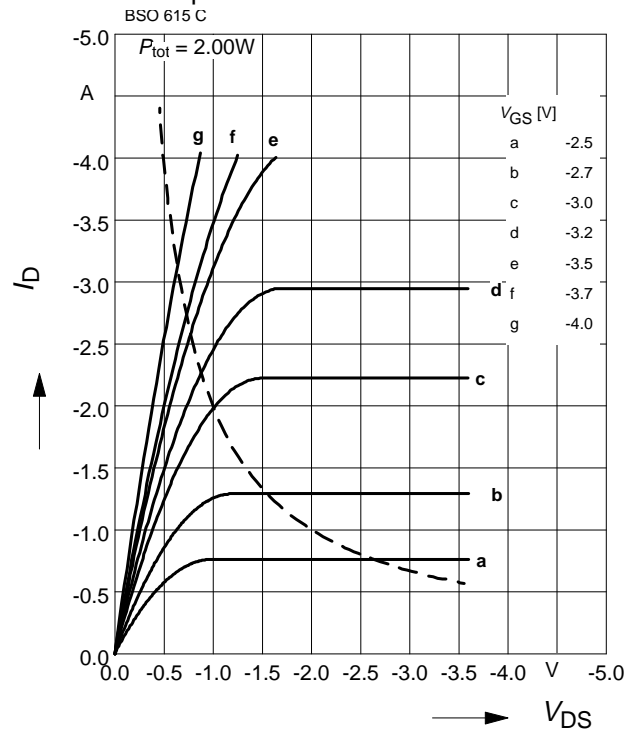
parameter: $t_p = 80 \mu s$



Typ. output characteristics (P-Ch.)

$$I_D = f(V_{DS})$$

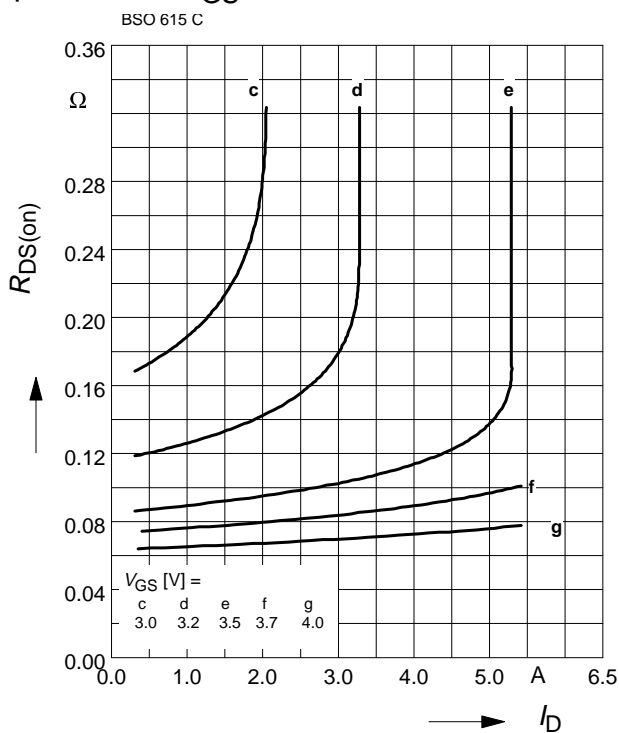
parameter: $t_p = 80 \mu s$



Typ. drain-source-on-resistance (N-Ch.)

$$R_{DS(on)} = f(I_D)$$

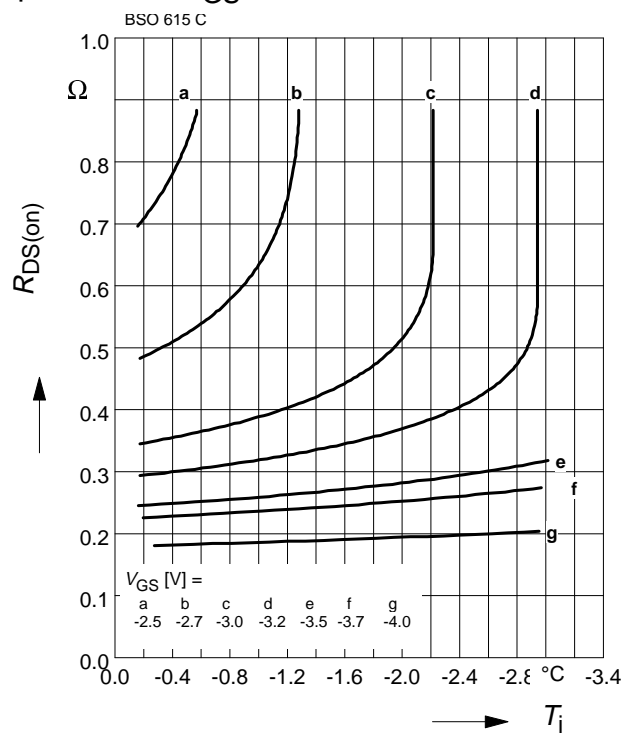
parameter: V_{GS}



Typ. drain-source-on-resistance (P-Ch.)

$$R_{DS(on)} = f(I_D)$$

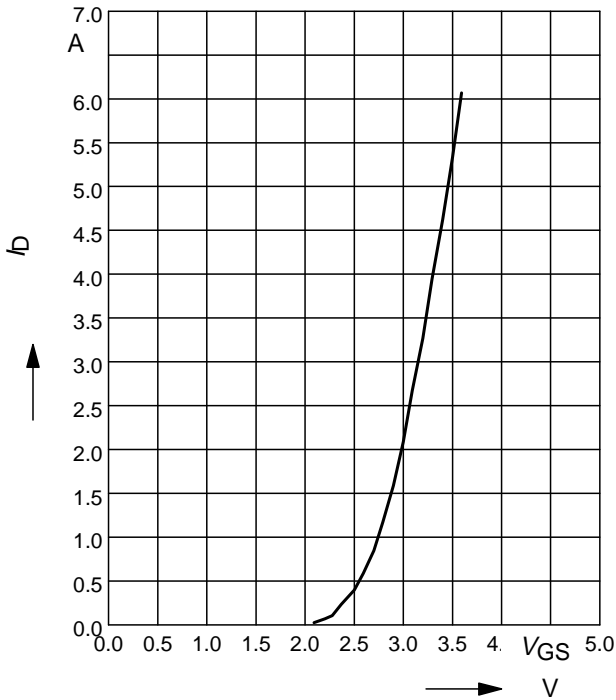
parameter: V_{GS}



Typ. transfer characteristics (N-Ch.)

parameter: $t_p = 80 \mu s$

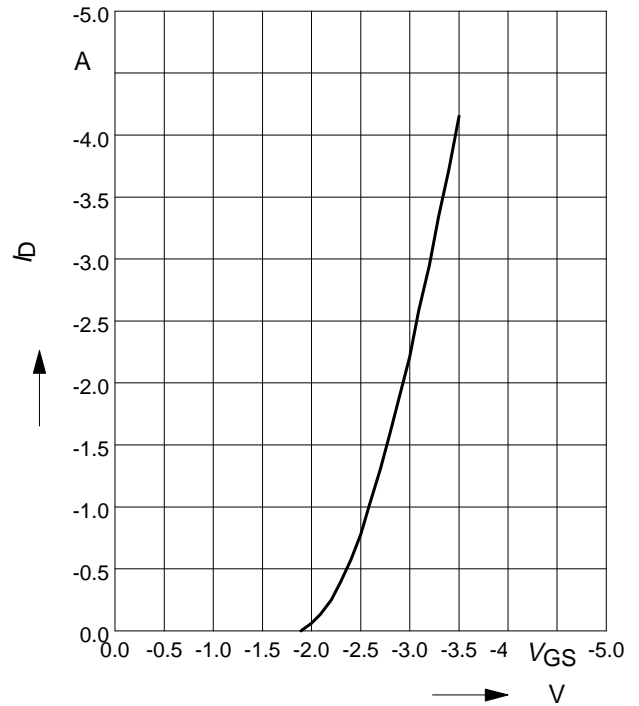
$I_D = f(V_{GS}), V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$



Typ. transfer characteristics (P-Ch.)

parameter: $t_p = 80 \mu s$

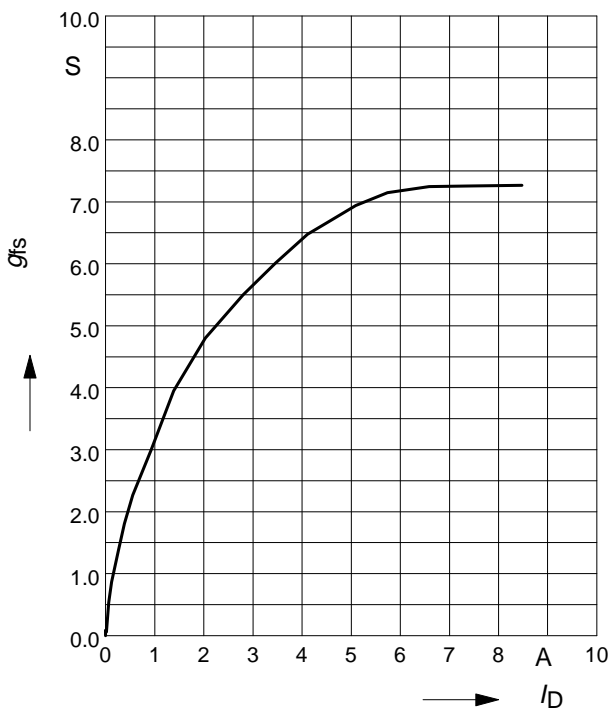
$I_D = f(V_{GS}), V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$



Typ. forward transconductance (N-Ch.)

$g_{fs} = f(I_D); T_j = 25 \text{ }^\circ\text{C}$

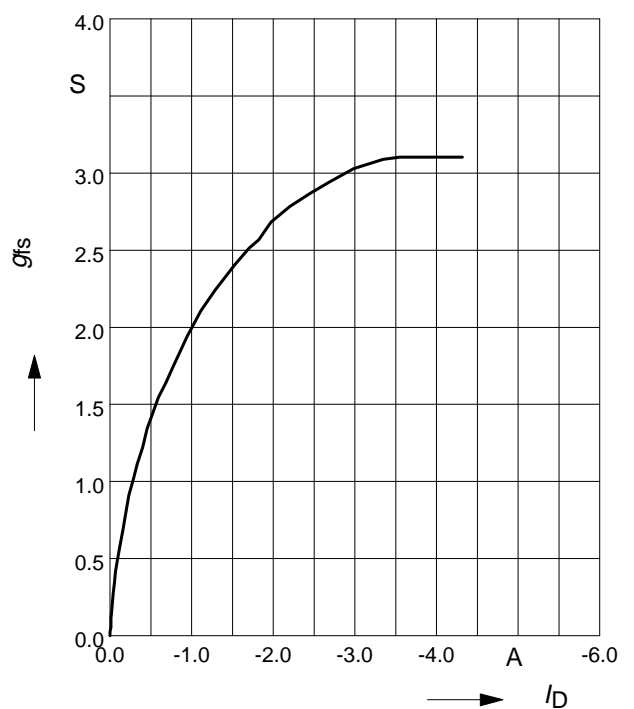
parameter: g_{fs}



Typ. forward transconductance (P-Ch.)

$g_{fs} = f(I_D); T_j = 25 \text{ }^\circ\text{C}$

parameter: g_{fs}

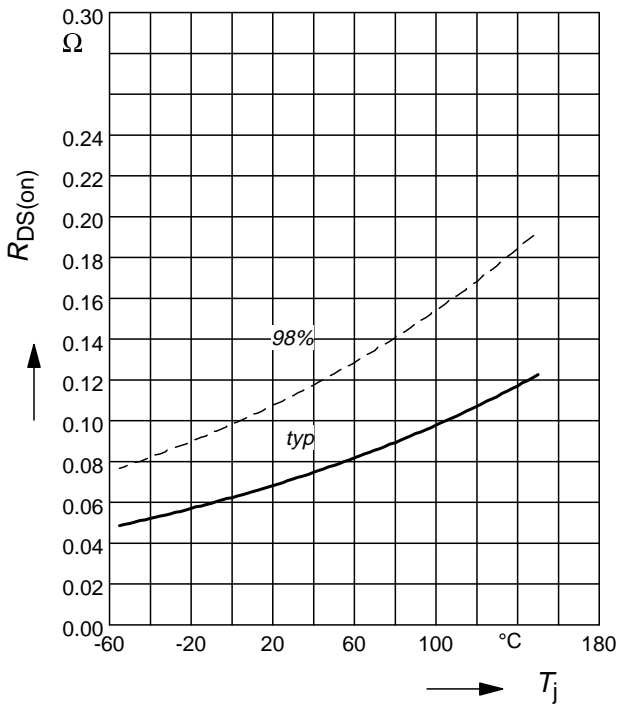


Drain-source on-resistance (N-Ch.)

$$R_{DS(on)} = f(T_j)$$

parameter : $I_D = 3.1 \text{ A}$, $V_{GS} = 10 \text{ V}$

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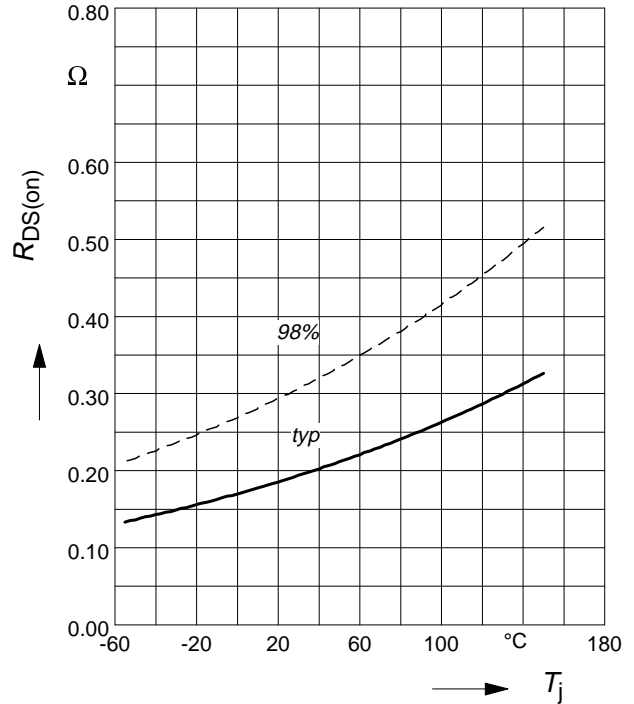


Drain-source on-resistance (P-Ch.)

$$R_{DS(on)} = f(T_j)$$

parameter : $I_D = -2 \text{ A}$, $V_{GS} = -10 \text{ V}$

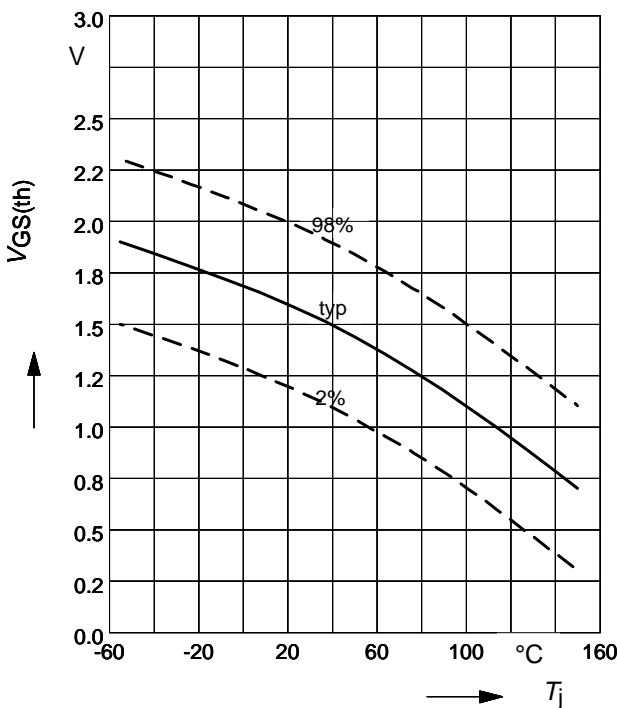
BSO 615 C



Gate threshold voltage (N-Ch.)

$$V_{GS(th)} = f(T_j)$$

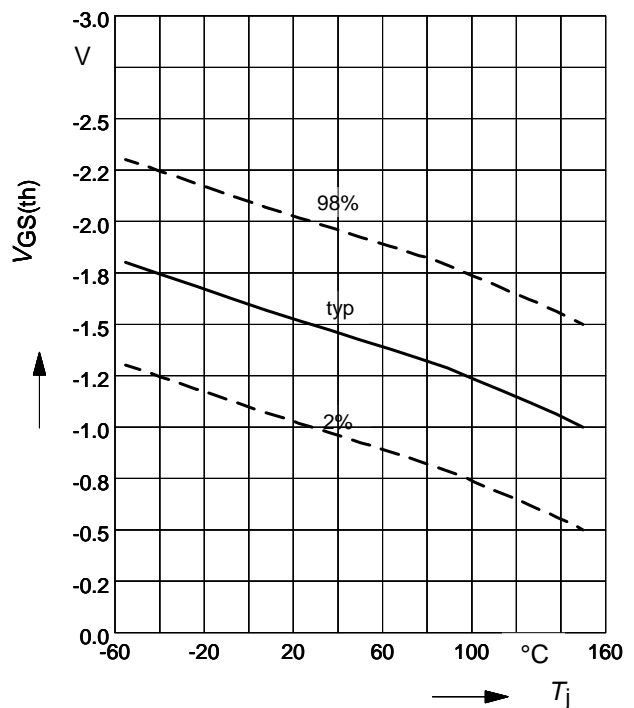
parameter: $V_{GS} = V_{DS}$, $I_D = 20 \mu\text{A}$



Gate threshold voltage (P-Ch.)

$$V_{GS(th)} = f(T_j)$$

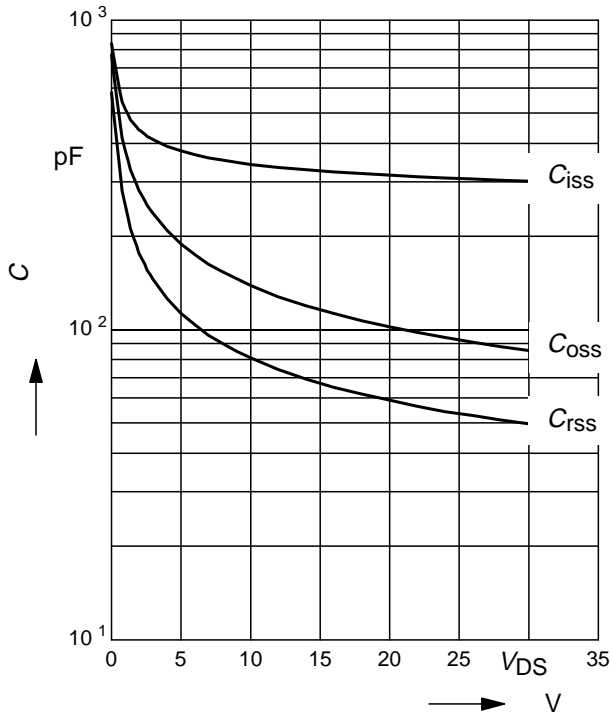
parameter: $V_{GS} = V_{DS}$, $I_D = -450 \mu\text{A}$



Typ. capacitances (N-Ch.)

$C = f(V_{DS})$

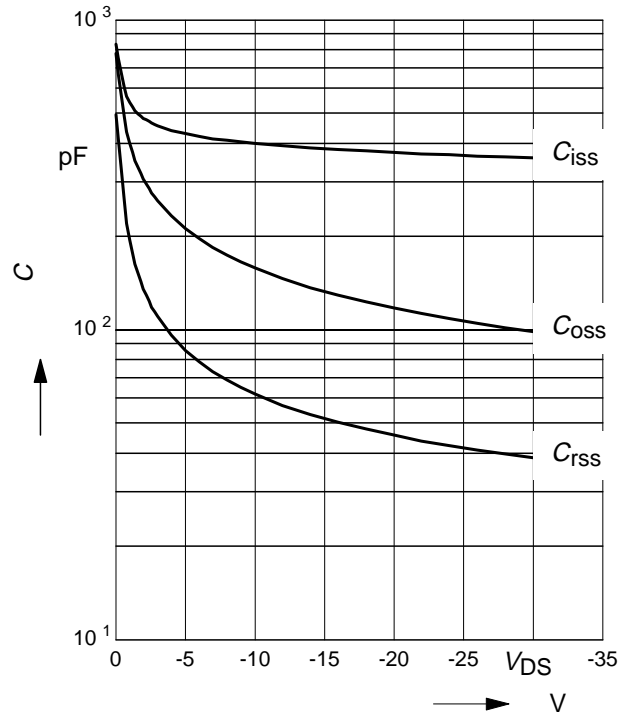
parameter: $V_{GS}=0\text{ V}$, $f=1\text{ MHz}$



Typ. capacitances (P-Ch.)

$C = f(V_{DS})$

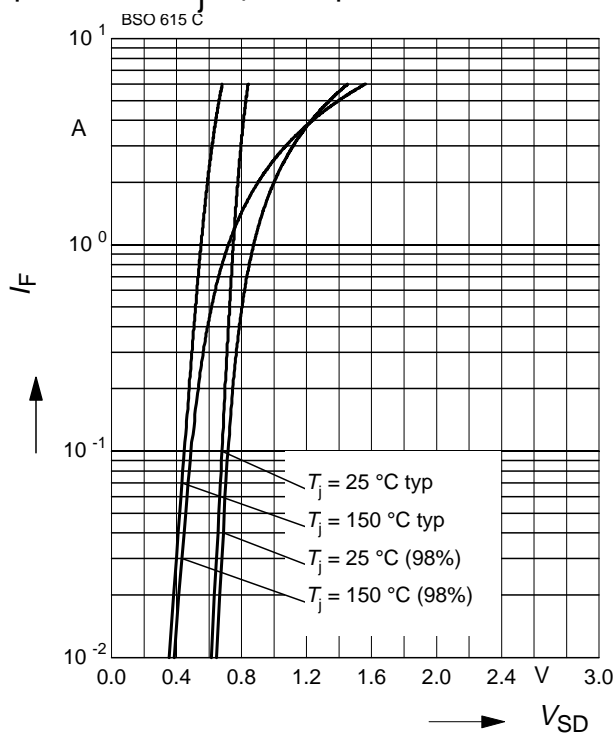
parameter: $V_{GS}=0\text{ V}$, $f=1\text{ MHz}$



Forward characteristics of reverse diode

$I_F = f(V_{SD})$, (N-Ch.)

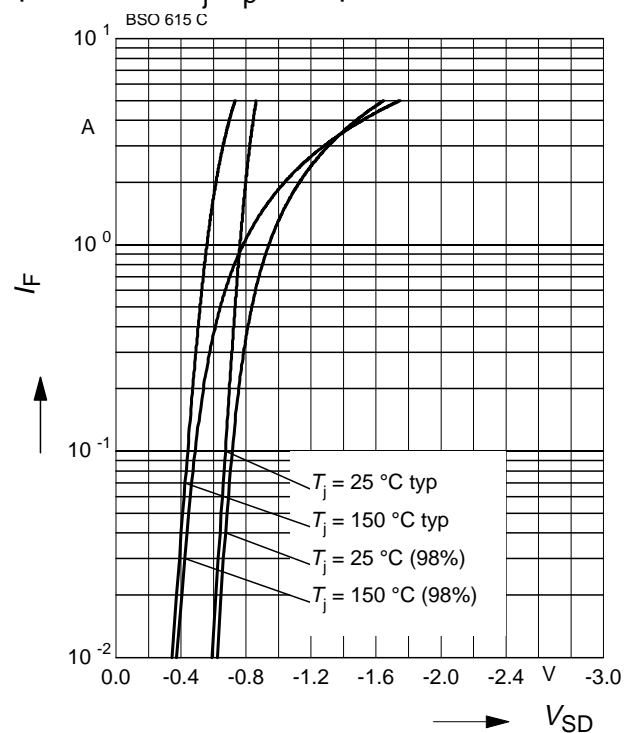
parameter: T_j , $t_p = 80\ \mu\text{s}$



Forward characteristics of reverse diode

$I_F = f(V_{SD})$, (P-Ch.)

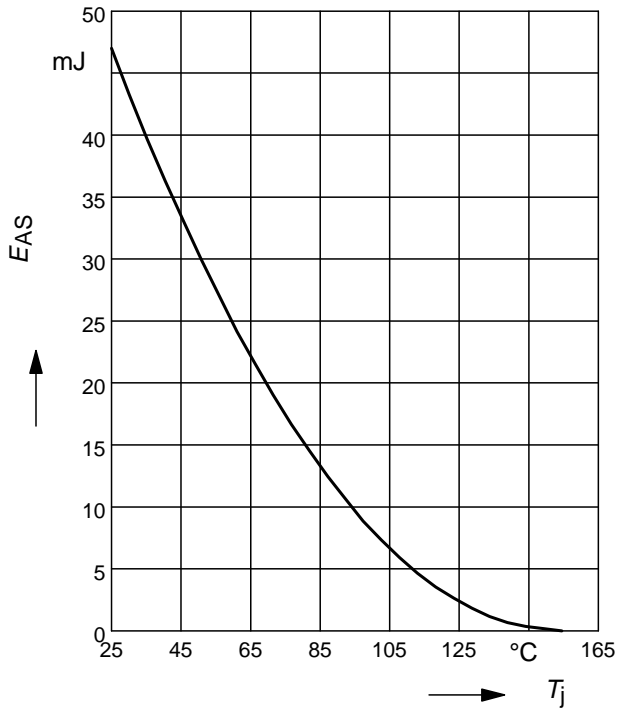
parameter: T_j , $t_p = 80\ \mu\text{s}$



Avalanche Energy $E_{AS} = f(T_j)$ (N-Ch.)

parameter: $I_D = 3.1 \text{ A}$, $V_{DD} = 25 \text{ V}$

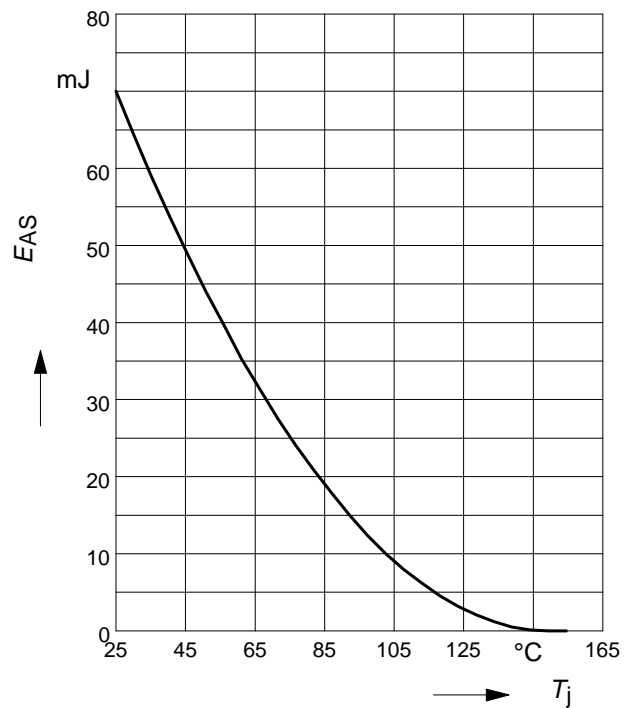
$R_{GS} = 25 \text{ } \Omega$



Avalanche Energy $E_{AS} = f(T_j)$

parameter: $I_D = -2 \text{ A}$, $V_{DD} = -25 \text{ V}$

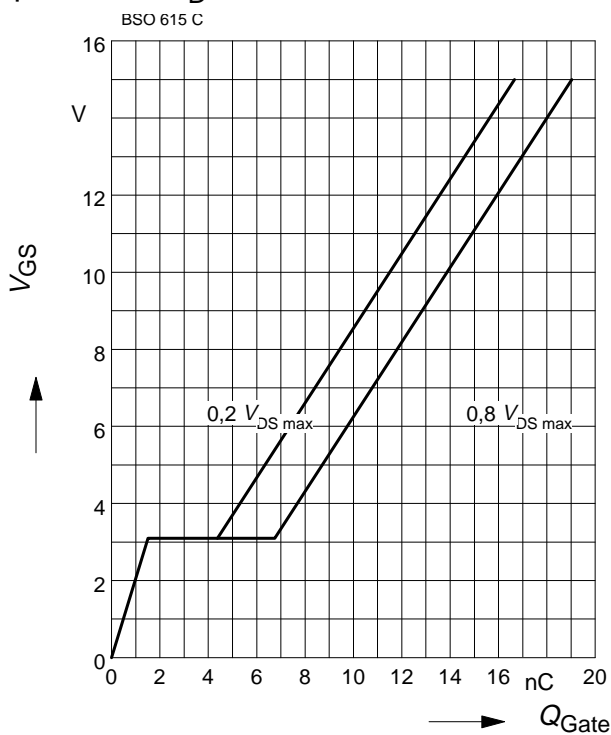
$R_{GS} = 25 \text{ } \Omega$



Typ. gate charge (N-Ch.)

$V_{GS} = f(Q_{Gate})$

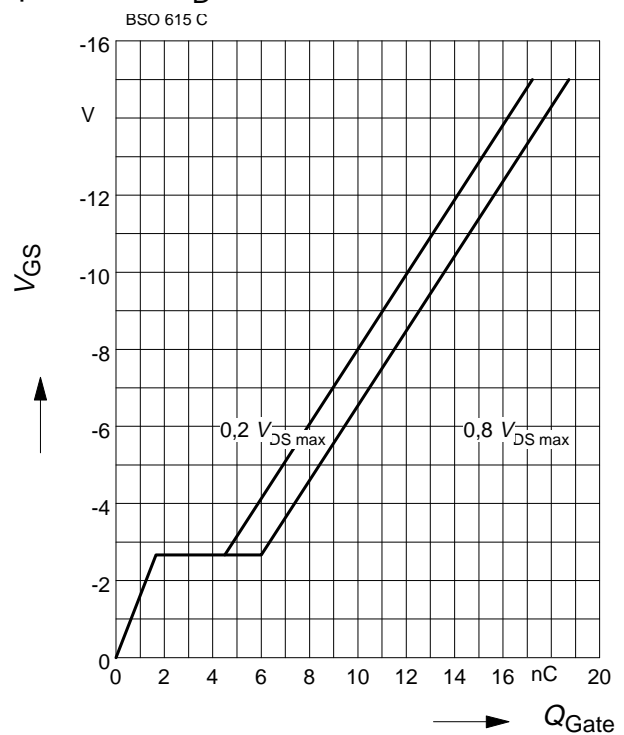
parameter: $I_D = 3.1 \text{ A}$



Typ. gate charge (P-Ch.)

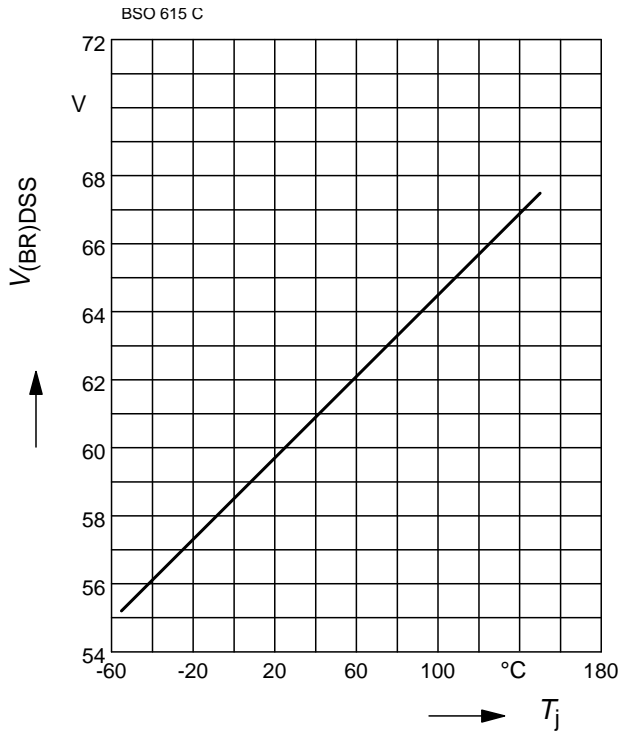
$V_{GS} = f(Q_{Gate})$

parameter: $I_D = -2 \text{ A}$



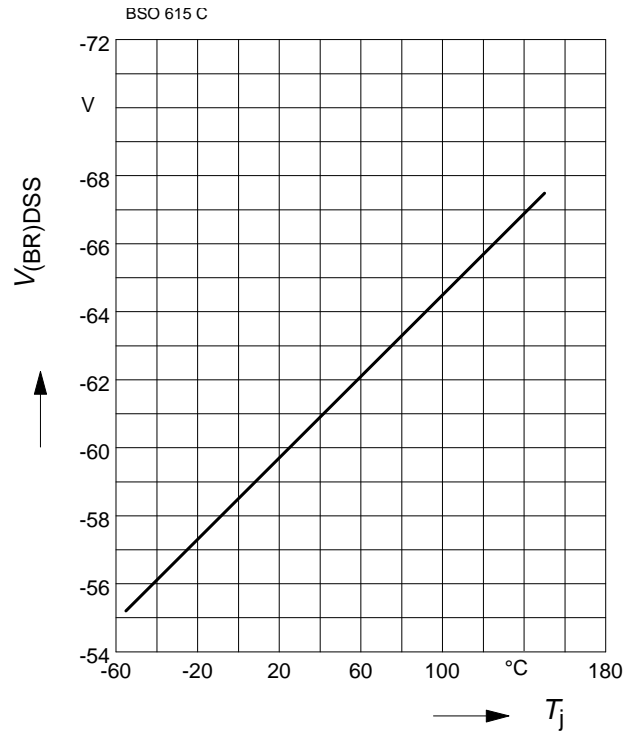
Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j), \text{ (N-Ch.)}$$



Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j), \text{ (P-Ch.)}$$



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